

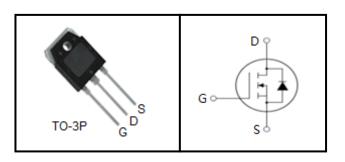
650V Super-Junction Power MOSFET

FEATURES

- Very low FOM $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



Device Marking and Package Information			
Device	Package	Marking	
TPV65R100A	TO-3P	65R100A	

Absolute Maximum Ratings $T_c = 25^{\circ}C$, unless otherwise noted					
Beremeter		Querra ha a l	Value		
Parameter	Symbol		TO-3P	Unit	
Drain-Source Voltage (V _{GS} = 0V)		V _{DSS}	650	V	
Continuous Drain Current		I _D	40	A	
Pulsed Drain Current	(note1)	I _{DM}	120	A	
Gate-Source Voltage		V _{GSS}	±30	V	
Single Pulse Avalanche Energy	(note2)	E _{AS}	720	mJ	
Avalanche Current	(note1)	I _{AR}	12	A	
Repetitive Avalanche Energy	(note1)	E _{AR}	1.5	mJ	
Power Dissipation ($T_c = 25^{\circ}C$)		P _D	400	W	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55~+150	°C	

Thermal Resistance				
Deservation	neter Symbol Value	Value	Unit	
Parameter	Symbol	TO-3P		
Thermal Resistance, Junction-to-Case	R _{thJC}	0.31		
Thermal Resistance, Junction-to-Ambient	R _{thJA}	62	K/W	



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Parameter	Symbol	Test Conditions	Value			
			Min.	Тур.	Max.	Unit
Static		•				
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_{D} = 250\mu A$	650			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1	μA
		V _{DS} = 650V, V _{GS} = 0V, T _J = 150°C			100	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 30V$			±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.5		4.0	V
Drain-Source On-Resistance (Note3)	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		0.09	0.1	Ω
Forward Transconductance (Note3)	g _{fs}	V _{DS} = 10V, I _D = 20A		40		S
Dynamic				•		
Input Capacitance	C _{iss}	$V_{GS} = 0V,$ $V_{DS} = 50V,$ f = 1.0MHz		5742		pF
Output Capacitance	C _{oss}			372		
Reverse Transfer Capacitance	C _{rss}			6.8		
Total Gate Charge	Qg			109		nC
Gate-Source Charge	Q _{gs}	$V_{DD} = 480V, I_{D} = 40A, V_{GS} = 10V$		28		
Gate-Drain Charge	Q _{gd}			40		
Turn-on Delay Time	t _{d(on)}			69.8		ns
Turn-on Rise Time	t _r	V _{DD} = 400V, I _D = 40A,		140		
Turn-off Delay Time	$t_{d(off)}$	$R_{\rm G} = 25\Omega$		239		
Turn-off Fall Time	t _f			31		
Drain-Source Body Diode Characteris	stics					
Continuous Body Diode Current	I _S				40	A
Pulsed Diode Forward Current	I _{SM}	T _C = 25°C			120	
Body Diode Voltage	V_{SD}	$T_J = 25^{\circ}C, I_{SD} = 40A, V_{GS} = 0V$		0.95	1.2	V
Reverse Recovery Time	t _{rr}			528		ns
Reverse Recovery Charge	Q _{rr}	V _R = 480V, I _F = I _S , di _F /dt = 100A/µs		7066		nC
Peak Reverse Recovery Current	l _{rrm}			27		А

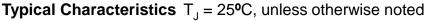
Notes

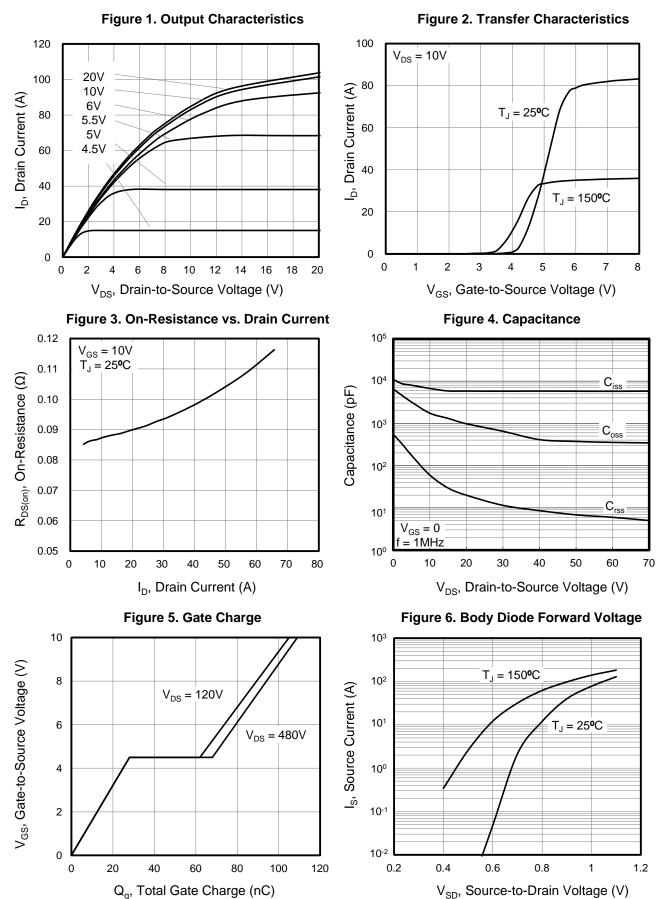
- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2. I_{AS} = 12A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 3. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 1%

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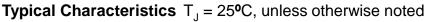


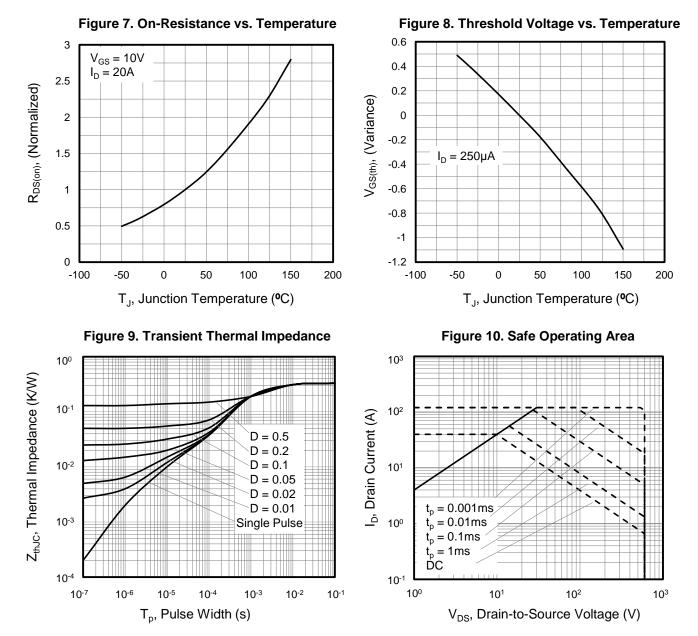
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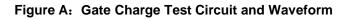












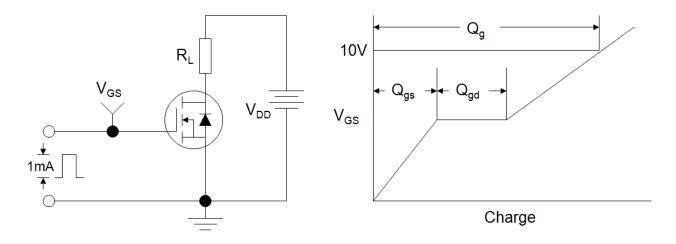


Figure B: Resistive Switching Test Circuit and Waveform

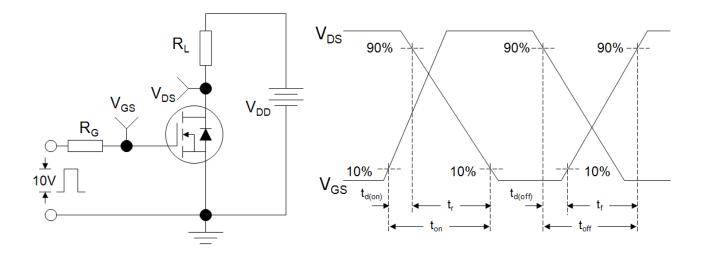
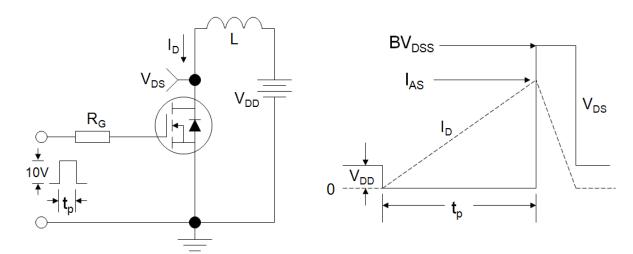


Figure C: Unclamped Inductive Switching Test Circuit and Waveform

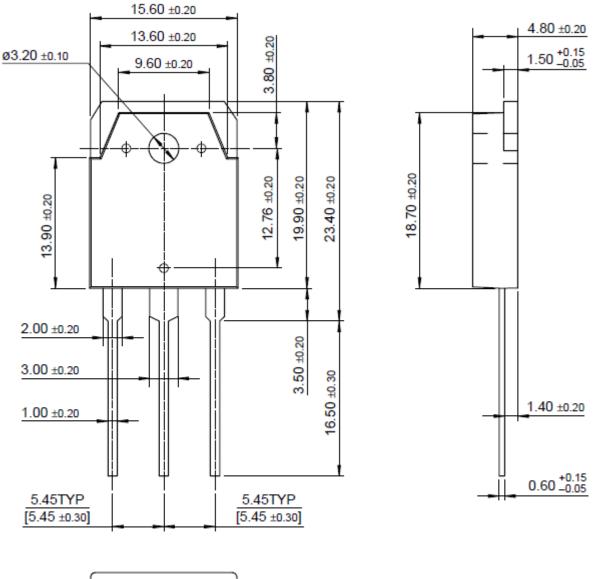




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TO-3P







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